

<b>Notice of References Cited</b>	Application/Control No. 10/695,352	Applicant(s)/Patent Under Reexamination JUNG ET AL.	
	Examiner Leslie J. Evanisko	Art Unit 2854	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,634,745	10-2003	Tanno, Koichi	347/107
	B	US-6,669,191	12-2003	Lee, Seung-Jae	271/189
	C	US-2004/0100545	05-2004	Kang, Sung-Wook	347/104
	D	US-2003/0057638	03-2003	Nakamura, Takao	271/264
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003-160270	06-2003	Japan	Matsuda, Takatomo	---
	O	JP 10-245143	09-1998	Japan	---	---
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.